

**Search Notes**

Application/Control No.

09/593,891

Examiner

Chris C. Chu

Applicant(s)/Patent under  
Reexamination

NAKAYAMA, SADA O

Art Unit

2815

**SEARCHED**

Class	Subclass	Date	Examiner
257	686, 692, 777, 778, 780 & 730	6/6/2005	C.C.
257	725 & 723	6/6/2005	C.C.
438	108 & 109	6/6/2005	C.C.
361	760	6/6/2005	C.C.

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
AS SAME	AS ABOVE	6/6/2005	C.C.

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Searched in US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; and IBM_TDB;	6/6/2005	C.C.